

**Search Notes**

Application/Control No.

10/021,080

Examiner

Jason Mitchell

Applicant(s)/Patent under  
Reexamination

BEST ET AL.

Art Unit

2193

**SEARCHED**

Class	Subclass	Date	Examiner
717	168,171	10/19/2005	
	120-123	10/19/2005	
709	223-226	10/19/2005	
370	254	10/19/2005	

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Search	10/19/2005	
Npl Search	10/19/2005	
EIC document Request	10/19/2005	